



OLED SPECIFICATION

Model No:

REX012864GWPP3N00000

CUSTOMER:

APPROVED BY	
PCB VERSION	
DATE	

FOR CUSTOMER USE ONLY

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1. Revision History

VERSION	DATE	REVISED PAGE NO.	Note
0	2013/09/23		First release
Α	2014/06/19		Update Rev.
В	2015/01/09		Modify Electrical
			Characteristics
			Modify Brightness
С	2015/01/16		Modify ICC
D	2015/02/25		Modify Interface
E	2015/05/12		Correct Contour
			Drawing
F	2015/12/08		Modify Life Time
G	2016/06/01		Modify Static
			electricity test
H	2017/09/22		Modify Reliability test
			Condition
	2017/12/19		Modify Reliability test
			Condition
J	2018/11/22		Modify Static
			electricity test
			Content of Test



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- 1.General Specification
- 2. Module Classification Information
- 3.Interface Pin Function
- 4. Contour Drawing & Block Diagram
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- 10.Inspection specification
- 11.Precautions in use of OLED Modules



1.General Specification

The Features is described as follow:

■ Module dimension: 60.5 × 37.0 × 2.15 mm

■ Active area: 55.01 × 27.49mm

■ Dot Matrix: 128 × 64

Dot size: 0.40 × 0.40 mmDot pitch: 0.43 × 0.43 mm

■ Display Mode : Passive Matrix

■ Duty: 1/64 Duty

Display Color: OLED, White
 Interface: 6800,8080,SPI,I₂C
 Controller IC: SSD1309Z

_ 0.75 0.40: .

■ SIZE: 2.42inch



2. Module Classification information

1	2	3	4	5	6	7	8	9	10	11	12	13	14
R	Е	Х	012864	G	W	Р	Р	3	N	0	0	0	00

1	Brand : Raystar 0	Optronics Inc.						
2	E: OLED							
3	Display Type X	: COB Character : COG : COG + FR + PCB : COG + PCB			OB Graphic OG + FR AB			
4	Dot Matrix: 128							
5	Series							
6	Emitting Color	A: Amber B: Blue G: Green S: Sky Blue	R : Red W : White Y : Yellow X : Dual Color		C : Full Color			
7	Polarizer		P : With Polarizer; N: Without Polarizer A : Anti-glare Polarizer					
8	Display Mode	P : Passive Matrix	; N : Active Matr	ix				
9	Driver Voltage	3:3.0~3.3V; 5	5: 5.0V					
10	Touch Panel	N: Without touch	panel; T: With tou	ich par	nel			
11	Product type	2 : Transparent OL	1 : Daylight Readable 2 : Transparent OLED (TOLED) 3 : Flexible OLED (FOLED)					
12	Inspection Grade	0 : Standard 2 : B grade C : Automotive grade Y : Consumer grad						
13	Option	Serial number(00~						
14	Serial No.	Serial Hullibel (00~	<u> </u>	,	10000000			



3.Interface Pin Function

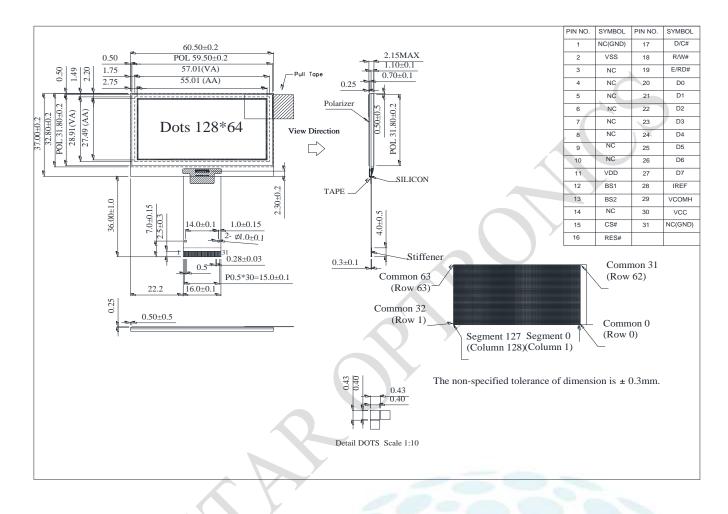
Pin No.	Symbol	Function				
1	NC(GND)	lo connection (ground.)				
2	Vss	Ground pin. It must be connected to external ground.				
3~10	NC	No connection				
11	Vdd	Power supply pin for core logic operation				
12	BS1	MCU bus interface selection pins. Select appropriate logic setting as				
		described in the following table.				
		BS1 BS2				
		I2C 1 0				
13	BS2	4-wire Serial 0 0				
	502	8-bit 68XX Parallel 0 1				
		8-bit 80XX Parallel 1 1				
		Note (1) 0 is connected to VSS (2) 1 is connected to VDD				
14	NC	No connection				
15	CS#	This pin is the chip select input connecting to the MCU. The chip is enabled for MCU communication only when CS# is pulled LOW (active LOW).				
16	RES#	This pin is reset signal input. When the pin is pulled LOW, initialization of the chip is executed. Keep this pin pull HIGH during normal operation.				
17	D/C#	This pin is Data/Command control pin connecting to the MCU. When the pin is pulled HIGH, the data at D[7:0] will be interpreted as ata. When the pin is pulled LOW, the data at D[7:0] will be transferred to a command egister. In 12C mode, this pin acts as SAO for slave address selection. When 3-wire serial interface is selected, this pin must be connected to SS. For detail relationship to MCU interface signals, refer to Timing				
		Characteristics				



18	R/W#	This pin is read / write control input pin connecting to the MCU interface. When 6800 interface mode is selected, this pin will be used as Read/Write (R/W#) selection input. Read mode will be carried out when this pin is pulled HIGH and write mode when LOW. When 8080 interface mode is selected, this pin will be the Write (WR#) input. Data write operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS.
19	E/RD#	This pin is MCU interface input. When 6800 interface mode is selected, this pin will be used as the Enable (E) signal. Read/write operation is initiated when this pin is pulled HIGH and the chip is selected. When 8080 interface mode is selected, this pin receives the Read (RD#) signal. Read operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS.
20~27	D0~D7	These pins are bi-directional data bus connecting to the MCU data bus. Unused pins are recommended to tie LOW. When serial interface mode is selected, D0 will be the serial clock input: SCLK; D1 will be the serial data input: SDIN and D2 should be kept NC. When I2C mode is selected, D2, D1 should be tied together and serve as SDAout, SDAin in application and D0 is the serial clock input, SCL.
28	IREF	This pin is the segment output current reference pin. IREF is supplied externally. A resistor should be connected between this pin and VSS to maintain the current around 10uA. Please refer to Figure 8-15 for the details of resistor value
29	VCOMH	COM signal deselected voltage level. A capacitor should be connected between this pin and VSS.
30	VCC	Power supply for panel driving voltage. This is also the most positive power voltage supply pin.
31	NC(GND)	No connection (ground.)

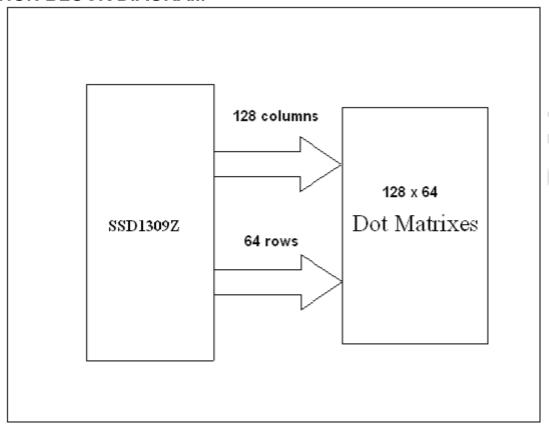


4. Contour Drawing & Block Diagram





FUNCTION BLOCK DIAGRAM



^{*}For more information, please refer to Application Note provided by Raystar Optronics.





5.Absolute Maximum Ratings

Parameter	Symbol	Min	Max	Unit	Notes
Supply Voltage for Logic	VDD	-0.3	4	V	1, 2
Supply Voltage for Display	VCC	0	15	V	1, 2
Operating Temperature	TOP	-40	+80	ů	_
Storage Temperature	TSTG	-40	+85	°C	-

Note 1: All the above voltages are on the basis of "VSS = 0V".

Note 2: When this module is used beyond the above absolute maximum ratings, permanent breakage of the module may occur. Also, for normal operations, it is desirable to use this module under the conditions according to Section 6 "Electrical Characteristics". If this module is used beyond these conditions, malfunctioning of the module can occur and the reliability of the module may deteriorate



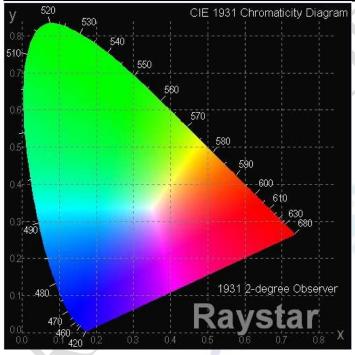
6.Electrical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
Supply Voltage for Logic	VDD	_	2.8	3.0	3.3	V
Supply Voltage for Display	VCC	_	12.0	13.0	15.0	V
High Level Input	VIH	_	0.8×VDD	_	VDD	>
Low Level Input	VIL	_	0	-,<	0.2×VDD	V
High Level Output	VOH	_	0.9×VDD	-	VDD	V
Low Level Input	VOL	_	0	-	0.1×VDD	V
50% Check Board operation Current	ng	VCC =13.0V	15.0	18.0	22.0	mA



7. Optical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
View Angle	(V)θ	_	160	_	_	deg
view / uigie	(Η)φ	_	160	_	-	deg
Contrast Ratio	CR	Dark	2000:1	-		
Response Time	T rise	_	_	10		μs
Treeponde Time	T fall	_	_	10		μs
Display with 50% check Board Brightness			70	90	_	cd/m2
CIEx(White)	(CIE1931)	0.26	0.28	0.30	_	
CIEy(White)		(CIE1931)	0.30	0.32	0.34	_





8.OLED Lifetime

ITEM	Conditions	Min	Тур	Remark
Operating Life Time	Ta=25°C / Initial 50% check board brightness Typical Value	20,000 Hrs	-	Note

Notes:

- 1. Life time is defined the amount of time when the luminance has decayed to <50% of the initial value.
- 2. This analysis method uses life data obtained under accelerated conditions to extrapolate an estimated probability density function (*pdf*) for the product under normal use conditions.
- 3. Screen saving mode will extend OLED lifetime.



9.Reliability

Content of Reliability Test

Environmenta	l Test				
Test Item	Content of Test	Test Condition	Applicable Standard		
High Temperature storage	Endurance test applying the high storage temperature for a long time.	85°C 240hrs	- (
Low Temperature storage	Endurance test applying the low storage temperature for a long time.	-40°C 240hrs			
High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	80°C 240hrs	7		
Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-40°C 240hrs			
High Temperature/ Humidity Storage	Endurance test applying the high temperature and high humidity storage for a long time.	60°C,90%RH 240hrs			
High Temperature/ Humidity Operation	Endurance test applying the high temperature and high humidity Operation for a long time.	60°C,90%RH 120hrs			
Temperature Cycle	Endurance test applying the low and high temperature cycle. -40°C 25°C 80°C 30min 5min 30min cycle	-40°C/80°C 30 cycles	500		
Mechanical Tes	st				
Vibration test	Endurance test applying the vibration during transportation and using.	Frequency:10~55Hz amplitude:1.5mm Time:0.5hrs/axis Test axis:X,Y,Z	-86		
Others					
Static electricity test	Endurance test applying the electric stress to the finished product housing.	Air Discharge model ±4kv,10 times			

^{***} Supply voltage for OLED system =Operating voltage at 25 $^{\circ}\mathrm{C}$



Test and measurement conditions

- 1. All measurements shall not be started until the specimens attain to temperature stability. After the completion of the described reliability test, the samples were left at room temperature for 2 hrs prior to conducting the failure test at 23±5°C; 55±15% RH.
- 2. All-pixels-on is used as operation test pattern.
- 3. The degradation of Polarizer are ignored for High Temperature storage, High Temperature/ Humidity Storage, Temperature Cycle

Evaluation criteria

- 1. The function test is OK.
- 2. No observable defects.
- 3. Luminance: > 50% of initial value.
- 4. Current consumption: within ± 50% of initial value.

APPENDIX:

RESIDUE IMAGE

Because the pixels are lighted in different time, the luminance of active pixels may reduce or differ from inactive pixels. Therefore, the residue image will occur. To avoid the residue image, every pixel needs to be lighted up uniformly.



10.Inspection specification

NO	Item	Criterion			AQL		
01	Electrical	1.1 Missing vertical, horizontal segment, segment contrast					
	Testing	defect. 1.2 Missing character , dot or icon.					
		1.3 Display malf		. 0	0011.		
		1.4 No function		ay.			0.65
		1.5 Current cons				pecifications.	0.00
		1.6 OLED viewii 1.7 Mixed produ	-	etec	t.		
		1.8 Contrast def	<i>,</i> ,				
		The Continuor do.					
02	Black or	2.1 White and b	lack spots	on c	display ≦0.25m	ım, no more than	
	white spots on	three white or bl	•	•			
	OLED	2.2 Densely spa	iced: No m	ore	than two spots	or lines within	2.5
	(display	3mm.					
	only)	0.45				, 	
03	OLED black	3.1 Round type following drawin			SIZE	Acceptable Q	
	spots,	$\Phi = (x + y) / 2$	g		SIZE	TY	
	white	X 1			Ф≦0.10	Accept no	
	spots,	→	→ H^ (← ↓			dense	
	contamina	3.2 Line type : (As following			0.10 <	2	2.5
	tion (non- display)				Ф≦0.20		
	(display)				0.20 <	1	
					Φ≦0.25	0	
				a dr	0.25<Φ	0	
		3.2 Line type . (/	Length		dth	Acceptable Q TY	
	, 1	,¥ w			≤0.02	Accept no dense	
		~	L≦3.0	0.0			2.5
		L. T. C.	L≦2.5	0.0	03 <w≦0.05< td=""><td>2</td><td></td></w≦0.05<>	2	
		0.0		0.0	05 <w< td=""><td>As round type</td><td></td></w<>	As round type	
04	Polarizer						
	bubbles	If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction.			ze Ф	Acceptable Q TY	
					≦0.20	Accept no dense	
					20<Φ≦0.50	3	2.5
					50<Φ≦1.00	2	0.60
					00<Φ	0	
				To	tal Q TY	3	



NO	Item	Criterion			AQL
05	Scratches	Follow NO.3 OLED b	lack spots, white spot	ts, contamination	
			/: Chip width z: C :: Glass thickness a: th:		
		6.1 General glass chi 6.1.1 Chip on panel s		ween panels:	7
06	Chipped glass	z: Chip thickness $Z \le 1/2t$ $1/2t < z \le 2t$ \odot If there are 2 or mo	y: Chip width Not over viewing area Not exceed 1/3k ore chips, x is total len	x: Chip length $x \le 1/8a$ $x \le 1/8a$ gth of each chip.	2.5
		z: Chip thickness	y: Chip width	x: Chip length	20
		Z≦1/2t	Not over viewing area	x≦1/8a	
		1/2t <z≦2t< td=""><td>Not exceed 1/3k</td><td>x≦1/8a</td><td></td></z≦2t<>	Not exceed 1/3k	x≦1/8a	
⊙ If there are 2 or more chips, x is the total length of each chip.					0



Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length 6.2 Protrusion over terminal: 6.2.1 Chip on electrode pad: y	NO	Item	Criterion	AQL		
k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length 6.2 Protrusion over terminal: 6.2.1 Chip on electrode pad: y: Chip width x: Chip length z: Chip thickness y≤0.5mm x≤1/8a 0 < z≤t 6.2.2 Non-conductive portion: Glass crack y: Chip width x: Chip length z: Chip thickness y≤L x≤1/8a 0 < z≤t olf the chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications. olf the product will be heat sealed by the customer, the alignment mark not be damaged. 6.2.3 Substrate protuberance and internal crack. y: width x: length						
L: Electrode pad length 6.2 Protrusion over terminal: 6.2.1 Chip on electrode pad: y: Chip width x: Chip length z: Chip thickness y≤0.5mm x≤1/8a 0 < z≤t 6.2.2 Non-conductive portion:		k: Seal width t: Glass thickness a: OLED side length				
6.2 Protrusion over terminal : 6.2.1 Chip on electrode pad : y: Chip width x: Chip length z: Chip thickness y ≤ 0.5mm x ≤ 1/8a 0 < z ≤ t 6.2.2 Non-conductive portion: y: Chip width x: Chip length z: Chip thickness y ≤ L x ≤ 1/8a 0 < z ≤ t						
Section Sec						
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$y \le 0.5 \text{mm} \qquad x \le 1/8a \qquad 0 < z \le t$ $6.2.2 \text{ Non-conductive portion:}$ $y : \text{Chip width} \qquad x: \text{Chip length} \qquad z: \text{Chip thickness} \qquad y \le L \qquad x \le 1/8a \qquad 0 < z \le t$ $0 : \text{If the chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications.}$ $0 : \text{If the product will be heat sealed by the customer, the alignment mark not be damaged.}$ $6.2.3 \text{ Substrate protuberance and internal crack.}$			6.2.1 Chip on electrode pad :			
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			y M			
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			1000	5-5		



NO	Item	Criterion	AQL
07	Cracked glass	The OLED with extensive crack is not acceptable.	2.5
08	Backlight elements	 8.1 Illumination source flickers when lit. 8.2 Spots or scratched that appear when lit must be judged. Using OLED spot, lines and contamination standards. 8.3 Backlight doesn't light or color wrong. 	0.65 2.5 0.65
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications.	2.5 0.65
10	PCB、COB	 10.1 COB seal may not have pinholes larger than 0.2mm or contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places. 10.5 No oxidation or contamination PCB terminals. 10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts. 10.7 The jumper on the PCB should conform to the product characteristic chart. 10.8 If solder gets on bezel tab pads, OLED pad, zebra pad or screw hold pad, make sure it is smoothed down. 	2.5 2.5 0.65 2.5 2.5 0.65 2.5
11	Soldering	 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 11.4 No short circuits in components on PCB. 	2.5 2.5 2.5 0.65



NO	Item	Criterion	AQL
		12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP.	2.5
		12.2 No cracks on interface pin (OLB) of TCP.	0.65
	General appearance	12.3 No contamination, solder residue or solder balls on product.	2.5 2.5
		12.4 The IC on the TCP may not be damaged, circuits. 12.5 The uppermost edge of the protective strip on the	2.5
12		interface pin must be present or look as if it cause the interface pin to sever.	2.5
12		12.6 The residual rosin or tin oil of soldering (component or	2.5
		chip component) is not burned into brown or black color.	0.65
		12.7 Sealant on top of the ITO circuit has not hardened.	0.65
		12.8 Pin type must match type in specification sheet. 12.9 OLED pin loose or missing pins.	0.65
		12.10 Product packaging must the same as specified on packaging specification sheet.	0.65
		12.11 Product dimension and structure must conform to product specification sheet.	
		A J Y	



Check Item	Classification	Criteria
No Display	Major	
Missing Line	Major	
Pixel Short	Major	
Darker Short	Major	
Wrong Display	Major	
Un-uniform B/A x 100% < 70% A/C x 100% < 70%	Major	A Normal B Dark Fixel C Light Fixel



11. Precautions in use of OLED Modules

- (1) Avoid applying excessive shocks to module or making any alterations or modifications to it.
- (2) Don't make extra holes on the printed circuit board, modify its shape or change the components of OLED display module.
- (3) Don't disassemble the OLED display module.
- (4) Don't operate it above the absolute maximum rating.
- (5) Don't drop, bend or twist OLED display module.
- (6) Soldering: only to the I/O terminals.
- (7) Storage: please storage in anti-static electricity container and clean environment.
- (8) It's pretty common to use "Screen Saver" to extend the lifetime and Don't use fix information for long time in real application.
- (9) Don't use fixed information in OLED panel for long time, that will extend "screen burn" effect time.
- (10) Raystar has the right to change the passive components, including R2and R3 adjust resistors. (Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.)
- (11) Raystar have the right to change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, Raystar have the right to modify the version.)

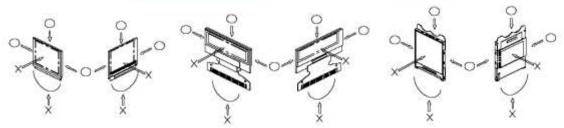
11.1 Handling Precautions

- (1) Since the display panel is being made of glass, do not apply mechanical impacts such us dropping from a high position.
- (2) If the display panel is broken by some accident and the internal organic substance leaks out, be careful not to inhale nor lick the organic substance.
- (3) If pressure is applied to the display surface or its neighborhood of the OLED display module, the cell structure may be damaged and be careful not to apply pressure to these sections.
- (4) The polarizer covering the surface of the OLED display module is soft and easily scratched. Please be careful when handling the OLED display module.
- (5) When the surface of the polarizer of the OLED display module has soil, clean the surface. It takes advantage of by using following adhesion tape.
- * Scotch Mending Tape No. 810 or an equivalent

Never try to breathe upon the soiled surface nor wipe the surface using cloth containing solvent Also, pay attention that the following liquid and solvent may spoil the polarizer:

- * Water
- * Ketone
- * Aromatic Solvents
- (6) Hold OLED display module very carefully when placing OLED display module into the System housing. Do not apply excessive stress or pressure to OLED display module. And, do not over bend the film with electrode pattern layouts. These stresses will influence the display performance. Also, secure sufficient rigidity for the outer cases.





- (7) Do not apply stress to the LSI chips and the surrounding molded sections.
- (8) Do not disassemble nor modify the OLED display module.
- (9) Do not apply input signals while the logic power is off.
- (10) Pay sufficient attention to the working environments when handing OLED display modules to prevent occurrence of element breakage accidents by static electricity.
- * Be sure to make human body grounding when handling OLED display modules.
- * Be sure to ground tools to use or assembly such as soldering irons.
- * To suppress generation of static electricity, avoid carrying out assembly work under dry environments.
- * Protective film is being applied to the surface of the display panel of the OLED display module. Be careful since static electricity may be generated when exfoliating the protective film.
- (11) Protection film is being applied to the surface of the display panel and removes the protection film before assembling it. At this time, if the OLED display module has been stored surface of the display panel after removed of the film. In such case, remove the residue material by the method introduced in the above Section 5.
- (12) If electric current is applied when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful to avoid the above.

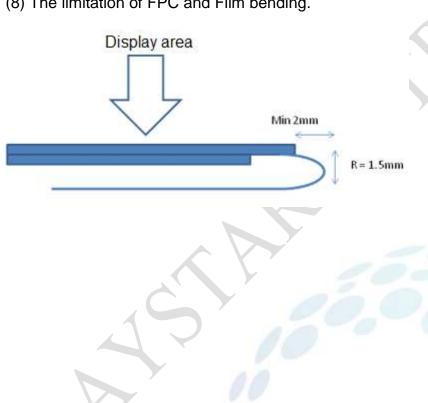
11.2 Storage Precautions

- (1) When storing OLED display modules, put them in static electricity preventive bags avoiding exposure to direct sun light nor to lights of fluorescent lamps. And, also, avoiding high temperature and high humidity environment or low temperature (less than 0°C) environments. (We recommend you to store these modules in the packaged state when they were shipped from Raystar Optronics Inc. At that time, be careful not to let water drops adhere to the packages or bags nor let dewing occur with them.
- (2) If electric current is applied when water drops are adhering to the surface of the OLED display module, when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful about the above.



11.3 Designing Precautions

- (1) The absolute maximum ratings are the ratings which cannot be exceeded for OLED display module, and if these values are exceeded, panel damage may be happen.
- (2) To prevent occurrence of malfunctioning by noise, pay attention to satisfy the VIL and VIH specifications and, at the same time, to make the signal line cable as short as possible.
- (3) We recommend you to install excess current preventive unit (fuses, etc.) to the power circuit (VDD). (Recommend value: 0.5A)
- (4) Pay sufficient attention to avoid occurrence of mutual noise interference with the neighboring
- (5) As for EMI, take necessary measures on the equipment side basically.
- (6) When fastening the OLED display module, fasten the external plastic housing section.
- (7) If power supply to the OLED display module is forcibly shut down by such errors as taking out the main battery while the OLED display panel is in operation, we cannot guarantee the quality of this OLED display module. Connection (contact) to any other potential than the above may lead to rupture of the IC.
- (8) The limitation of FPC and Film bending.





		Page: 1			
Module Sample Estimate Feedback Sheet					
Module Number :					
1 · Panel Specification :					
1. Panel Type:	□ Pass	□NG ,			
2. Numbers of Pixel:	□ Pass	□NG ,			
3. View Area:	□ Pass	□NG ,			
4. Active Area:	□ Pass	□NG ,			
5.Emitting Color:	□ Pass	□NG ,			
6.Uniformity:	□Pass	□NG ,			
7.Operating	□ Pass	□NG ,			
Temperature :					
_ 8.Storage	□ Pass	□NG ,			
Temperature :					
9.Others :					
2 · <u>Mechanical Specifica</u>					
1. PCB Size :	□Pass	□NG ,			
2.Frame Size :	□Pass	□NG ,			
3.Materal of Frame:	□Pass	□NG ,			
4.Connector Position:	□Pass	□NG ,			
5.Fix Hole Position:	□Pass	□NG ,			
6. Thickness of PCB:	□Pass	□NG ,			
7. Height of Frame to	□Pass	□NG ,			
PCB:	Y				
8.Height of Module:	□Pass	□NG ,			
9.Others:	□Pass	□NG ,			
3 · Relative Hole Size :					
1.Pitch of Connector:	□Pass	□NG ,			
2.Hole size of □Pass		□NG ,			
Connector:	00				
3.Mounting Hole size : □Pass		□NG ,			
4.Mounting Hole Type:	□Pass	□NG ,			
5.Others:	□Pass	□NG ,			

□Pass □NG ,_____ >> Go to page 2 <<



Page: 2 Module Number :			
ics of Modu	ıle :		
□Pass	□NG ,		
□Pass	□NG ,		
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